

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/628,652	KASPER ET AL.	
Examiner	Art Unit	
Ren L. Yan	2854	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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